Applicant(s)/Patent Under Application/Control No. Reexamination 10/603,736 LEPPANEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Eugene H Eickholt 2854 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,729,235 05-2004 Kerr, Roger S. 101/415.1 US-6,729,234 05-2004 Shih, Richard T. 101/389.1 В US-6,505,551 01-2003 Kawabe et al. 101/116 С 101/389.1 US-6,457,410 10-2002 Zerillo, Samuel D. D Ε US-6,382,096 05-2002 Watanabe, Hiroshi 101/128.1 01-2002 Asai et al. US-6,334,393 101/477 F US-5,503,075 04-1996 Matsuo et al. 101/477 G 07-1985 Н US-4,528,906 Hasegawa, Takanori 101/127.1 US-4,167,346 09-1979 Holland-Letz, Guenter 400/618 US-3,802,546 04-1974 Helms, Clifford J. 400/618 J US-3,550,745 12-1970 TESSITORE ARMANDO; et. al. 400/618 US-Ļ US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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